

Anbotek

Report No.:1821C40001812504 FCC ID:XUJCRELITEA

9.2. Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3. Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

La L	-10 811	7.00
	≤ 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	5 ± 1 mm	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	30° ± 1°	20° ± 1°
	\leq 2 GHz: \leq 15 mm 2 – 3 GHz: \leq 12 mm	$3 - 4 \text{ GHz:} \le 12 \text{ mm}$ $4 - 6 \text{ GHz:} \le 10 \text{ mm}$
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension o measurement plane orientation the measurement resolution r x or y dimension of the test d measurement point on the test	on, is smaller than the above, must be \leq the corresponding evice with at least one







9.4. Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label.

Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

VA V			≤ 3 GHz	> 3 GHz
VUpo.	400	"poro Viv	~ ~018 h	Yun. 16k
Maximum zoom scan spatial resolution: Δx _{Zoom} , Δy _{Zoom}			\leq 2 GHz: \leq 8 mm 2 - 3 GHz: \leq 5 mm	$3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$
	uniform	grid: Δz _{Zoom} (n)	≤ 5 mm	3 – 4 GHz: ≤ 4 mm 4 – 5 GHz: ≤ 3 mm 5 – 6 GHz: ≤ 2 mm
Maximum zoom scan spatial resolution, normal to phantom surface graded grid	graded	Δz _{Zoom} (1): between 1 st two points closest to phantom surface	≤ 4 mm	3 – 4 GHz: ≤3 mm 4 – 5 GHz: ≤2.5 mm 5 – 6 GHz: ≤2 mm
	grid	Δz _{Zoom} (n>1): between subsequent points	≤1.5·Δ	z _{Zoom} (n-1)
Minimum zoom scan volume	x, y, z		≥ 30 mm	$3 - 4 \text{ GHz:} \ge 28 \text{ mm}$ $4 - 5 \text{ GHz:} \ge 25 \text{ mm}$ $5 - 6 \text{ GHz:} \ge 22 \text{ mm}$

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

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When zoom scan is required and the <u>reported</u> SAR from the <u>area scan based 1-g SAR estimation</u> procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.





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9.5. Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregateSAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6. Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.





10. Conducted Power

<WLAN 2.4GHz Conducted Power>

Mode	Channel	Frequency (MHz)	Conducted Average Output Power(dBm)	Tune-up power(dBm)
	ANTON	2412	14.67	15.00
802.11b	6 nbote	2437	14.29	14.50
	₃ / ₄ 11	2462	14.69	15.00
	1	2412	14.50	15.00
802.11g	100 Tee 6	2437	14.03	14.50
	nb49	2462	13.65	14.00
	Totek	2412	14.30	14.50
802.11n20	6	2437	13.74	14.00
	11 ^{Anba}	2462	13.57	14.00
	18 Y	2422	14.13	14.50
802.11n40	"ote ⁴ 6	2437	14.16	14.50
	9,4	2452	14.09	14.50
Yo.	2000	V-	2010	1,1

Note:

1. Per KDB 447498 D01, the 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at *test separation distances* ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

- 2. Base on the result of note1, RF exposure evaluation of 2.4G WIFI mode is required.
- 3. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.
- 4. Per KDB 248227 D01, In the 2.4 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4 GHz OFDM conditions:
 - 1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.
 - 2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.







<Bluetooth Conducted Power>

Mode	Channel	Frequency (MHz)	Conducted Peak Power (dBm)	Conducted Average Power (dBm)	Tune-up power(dBm)
BT BDR	00	2402	5.04	2.69	3.00
(GFSK)	39	2441	6.38	3.98	4.00
(GFSK)	78	2480	6.02	3.01	3.50
BT EDR	00 abotel	2402	5.14	2.31	2.50
(Π/4DQPSK)	39	2441	4.96	Anbote 1.26 Anbot	1.50
(II/4DQF3K)	78 And	2480	3.42	1.23	1.50
BT EDR	abotek00	2402	3.34 Anbore	1.22	1.50
(8DPSK)	39	2441	5.04	2.66	3.00
(obrak)	78	2480	3.95	2.33	2.50
DT DIE 1M	00	2402	1.81	note 0.21 Anbote	0.50
BT BLE_1M	19 _{Anbore}	2440	1.94	0.26	0.50
(GFSK)	ntek 39 An	2480	2.22	And 1.77	notek 2.00 nboto

Note:

Per KDB 447498 D01v05r02, the 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

o'	Bluetoo	oth Max. Pow	ver (dBm)	Separation Dist	tance (mm)	Frequency (G	SHz)	exclusion thresholds
	botek	4.00	Vun Polek	Anbotek 5	Aupo	2.441	Anb	0.80

Per KDB 447498 D01, when the minimum test separation distance is <10 mm, a distance of 10 mm is applied to determine SAR test exclusion. The test exclusion threshold is 0.80 which is<= 3, SAR testing is not required.

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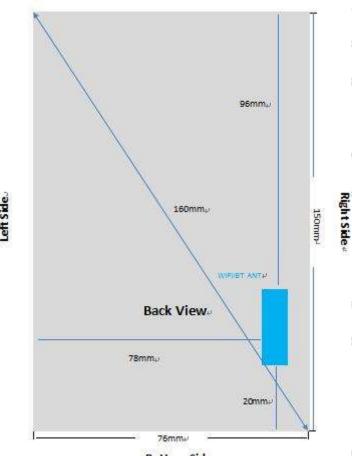
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11. Antenna Location

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Top Side



Bottom Side

3	Positions for SAR tests; Body mode							
Α	Antennas Front Back Top Side Bottom Side Left Side Right Side							
V	WIFI/BT	Dole, Nos	- Was	Ma An	100 acV-You	tek Na Aupor	Non wo	
	ANT	Yes	Yes	No	Anbotek Yes Anb	No No	otek Yes Anbo	

General Note: According with FCC KDB 447498 D01, appendix A, <SAR test exclusion thresholds for 100MHz~6GHz and≤50mm>table, this device SAR test configurations considerations are shown in the table above.

Per KDB 447498 D01, for larger devices, the test separation distance of adjacent edge configuration is determined by the closest separation between the antenna and the user.

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12. SAR Test Results Summary

General Note:

1.Per KDB 447498 D01v06, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.

Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor

- 2.Per KDB 447498 D01v06, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary
- 3.Per KDB865664 D01, for each frequency band, repeated SAR measurement is required only when the measured SAR is ≥0.8W/Kg; if the deviation among the repeated measurement is ≤20%,and the measured SAR <1.45W/Kg, only one repeated measurement is required.
- 4. When the user enables the personal Wireless router functions for the handsets, actual operations include simultaneous transmission of both the Wi-Fi transmitting frequency and thus cannot be evaluated for SAR under actual use conditions. The "Portable Hotspot" feature on the handset was

NOT activated, to ensure the SAR measurements were evaluated for a single transmission frequency RF signal.

12.1. Body-worn SAR Results

<WIFI>

						Freq.	Averag	Tune-U	Scalin	Powe	Measure	Reporte
Plot	Band	Mode	Test	Gap	Ch.		e	р		r	d	d
No.	Dallu	Mode	Position	(mm)		(IVITIZ	Power	Limit	g Fastar	Drift	SAR _{1g}	SAR _{1g}
						'	(dBm)	(dBm)	Factor	(dB)	(W/kg)	(W/kg)
V.	WIFI2.4GHz	802.11b	Left	0,0%	11	2462	14.69	15.00	1.074	N/A	N/A M	N/A
"spore"	WIFI2.4GHz	802.11b	Right	VU.0	11	2462	14.69	15.00	1.074	0.07	0.311	0.334
odn	WIFI2.4GHz	802.11b	Тор	Oupe	11	2462	14.69	15.00	1.074	N/A	N/A	N/A
h.	WIFI2.4GHz	802.11b	Bottom	0	nb14er	2462	14.69	15.00	1.074	0.05	0.082	0.088
P	WIFI2.4GHz	802.11b	Front	0	11,	2462	14.69	15.00	1.074	0.13	0.258	0.277
#1	WIFI2.4GHz	802.11b	Back	0	11	2462	14.69	15.00	1.074	0.11	0.436	0.468
orek	WIFI2.4GHz	802.11b	Mack N	000	1	2412	14.67	15.00	1.079	-0.06	0.428	0.462
~otek	WIFI2.4GHz	802.11b	Back	0 tel	6	2437	14.29	14.50	1.050	-0.02	0.389	0.408

Note:

- 1. Per KDB 865664 D01V01,for each frequency band ,repeated SAR measurement is required only when the measured SAR is≥0.8W/Kg.
- 2. Per KDB 865664 D01V01,if the ratio of largest to smallest SAR for the original and first repeated measurement is≤1.2and the measured SAR<1.45W/Kg, only one repeated measurement is required.
- 3. Perform a second repeated measurement only if the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20 or when the original or repeated measurement is ≥ 1.45W/Kg
- 4. The ratio is the difference in percentage between original and repeated measured SAR.





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13. Simultaneous Transmission Analysis

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Simultaneous TX SAR Considerations

No. Applicable Simultaneous Transmission

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1. N/A

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Note:

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1. WIFI 2.4GHz and Bluetooth share the same antenna, and cannot transmit simultaneously.

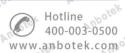
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Code:AB-RF-05-b





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14. Measurement Uncertainty

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NO	Anbotek Anbotek Anbotek Anbotek	Uncert.	Prob. Dist.	Div. k	ci (1g)	ci (10g)	Stand.U ncert. ui (1g)	Stand.U ncert. ui (10g)	Veff
Anbo 1	Repeat	0. 4	N _{Anbo'}	2 ^N 1	Anbo	te. 1 abotek	0.4	0.4	ipotek 9
	Aupotek Aupo	Anbol	Instru	ıment	ek P	", "pok	ak Ar	poter	Ann
2	Probe calibration	7 🔯	potek N	Anbo.	Majo	1,0	3.5	3.5	∞
olek.	Vuporg, Vun	40.	Polek	PL	(D)		nbotek	Aupole	VIII
Anbore	Axial isotropy	4.7	Amo Rotek	_ \dag{3}	0.7	0.7	1.9	1.9	nbotek nbotek
An	Dolek Williams	Aupolok	Vug.	nbotek		Anborek	Vupo	obotek	Anbotek
4	Hemispherical isotropy	9.4 Anbo	R	√3	0.7	0.7	3.9	3.9	∞ ote
5	Boundary effect	1.0	nbolek Rek	 √3	potek	1 0	0.6	0.6	∞ Anl
16 ^{bol}	Linearity	4.7	Ribotel	 √3	00	otek	2.7	2.7 And	nbo1∞
7	Detection limits	1.0	otek R	 √3	1	Anborek	0.6	0.6	Anbotek ∞
8/0/	Readout electronics	0.3	nbotek N	1 nb	1	Arra 1	0.3	0.3	∞
hotek	Anborek Anbo	rek	Anbolek	_1	rupo.	N.	abolek	Anbore	r Vu
Inbotes	Response time	0.8	R	√3	Antol	1	0.5	0.5	otek ∞
10 ₄	Integration time	2.6	R An	√3	, 1	bolek Jolel	1.5	1.5	Vupojek ∞ ojek
11	Ambient noise	3.0	otek otek	_ √3	o ^{tek} 1	1 Ant	1.7	1.7 ^{1.6}	∞ Anbo
12	Ambient reflections	3.0	AR AROLEK	_ √3	Anbotek	cek 1	1.7 tek	1.7	∞
13	Probe positioner mech. restrictions	0.4	Anbo	_ √3	1 1	nbotek	0.2	0.2	V _{II} ∞
-4e	Probe positioning with	And An	potek	Anbor	10%	Anbo	ootek k	Anborek	Anbore
polek 14	respect to phantom	2.9	Anbotek Anbotek	√3	Anbolek	1	Anbalek	Anbotek 1.7	N M
Pupole	shell	Anbotek Anbotek		lek _	0/2	2501		V	apolon
15	Max.SAR evaluation	1.0	R	√3	1	Anbolok	0.6	0.6	∞

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Vupole.	VIII	-bote-CC	ID:XUJC	NELI	IEA	ek /	Aupole	b.	1/91
Anb.	otek Anbotek A	, nbotek	Anbore	No.	Aupo	hotek	Anbore	P. V.	lootek
1	Aupotek Aupor	Anbore	Test samp	ole rel	ated	Aupole	K An	potek potek	Anbotek
16	Device positioning	1.6× 3.8	Anbo N	1Anh	otek 1	Anh 1	3.8	3.8	99
17	Device holder	5.1	AN	_e × 1	Anbound Anbo	ke ^k 1	15.1	5.1	100 ¹⁶ 5
18	Drift of output power	5.0 ₀ 00	ek R A	√3	. 1	nbotek	2.9	2.9	Anbotek
OF.	Aupotek Aupote	b.	│ Phantom a	Vupop	et-up	And	bolek	Anbotok	Anbo nb
19	Phantom uncertainty	4.0	Anbolek Rotek	√3 -	Anhotel	1	2.3	2.3	∞
20	Liquid conductivity (target)	5.0	R Anbo	3.7	0.64	0.43	1.8 ^k nb ^c	1.2	NH Wek
21	Liquid conductivity (meas)	2.5	upotek N	Anbo	0.64	0.43	1.6	1.2	Anbote
22	Liquid Permittivity (target)	5.0	Anboten Ribotek	√3	0.6	0.49	Anbotek 1. Zotek Anbotek	1.5	∞ orek
23	Liquid Permittivity (meas)	2.5	otek N	Anb Nek	0.6	0.49	1.5	1.2	Anbo Ariotek
otek	Anbotek Anboten	ick bus	Inpotek	Anbr	Jek Ck	Vup.	upotek	Aupotek	k Vupo,
Anbotek	Combined standard	nbolek	RSS	U	$_{C} \equiv \sqrt{\sum_{i=1}^{n}}$	$C_i^2 U_i^2$	11.4%	11.3%	236
Anbo	Expanded ertainty(P=95%)	Anbote	k Vu	 = k	ι ,k=2	Anbotel Anbotel	22.8%	22.6%	Aupotek Vapotek

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Appendix A. EUT Photos and Test Setup Photos





Body Front(0mm)

Body Back(0mm)



Body Bottom(0mm)



Body Right(0mm)









Appendix B. Plots of SAR System Check

2450MHz Head System Check

Date: 09/19/2024

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: 910

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): f = 2450 MHz; $\sigma = 1.85 \text{S/m}$; $\epsilon r = 39.08$; $\rho = 1000 \text{ kg/m}3$

Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: May 06, 2024;

Sensor-Surface: 3mm (Mechanical Surface Detection)
Electronics: DAE4 Sn387; Calibrated: Sep.02.2024;

Phantom: SAM 1; Type: SAM;

Measurement SW: DASY52, Version 52.8 (1); SEMCAD X Version 14.6.5 (6469)

Area Scan (61x91x1):Measurement grid: dx=10.00 mm, dy=10.00 mm

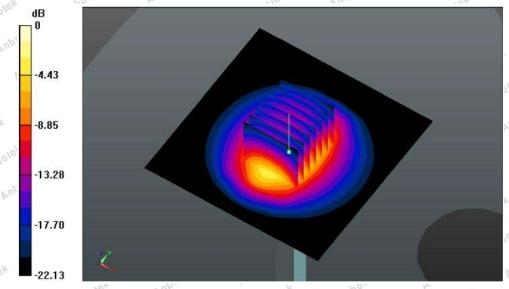
Maximum value of SAR (interpolated) = 19.664 W/kg

Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 84.571 V/m; Power Drift = 0.05 dB

Peak SAR (extrapolated) = 26.125 W/kg

SAR(1 g) = 12.95 W/kg; SAR(10 g) = 5.92 W/kg Maximum value of SAR (measured) = 19.47W/kg



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Appendix C. Plots of SAR Test Data

#1 Date: 09/19/2024

WIFI 2.4G_802.11b_Body Back_Ch11

Communication System: UID 0, wifi (fcc) (0); Frequency: 2462 MHz; Duty Cycle: 1:1

Medium parameters used (interpolated): f = 2462 MHz; $\sigma = 1.85$ S/m; $\varepsilon_r = 39.08$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

DASY5 Configuration:

•Probe: EX3DV4 - SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: May 06.2024;

•Sensor-Surface: 4mm (Mechanical Surface Detection)

•Electronics: DAE4 Sn387; Calibrated: Sep.02,2024

•Phantom: SAM 1; Type: SAM;

•Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY/Back /Area Scan (91x161x1): Measurement grid: dx=1.200mm, dy=1.200mm

Maximum value of SAR (measured) = 1.756 W/kg

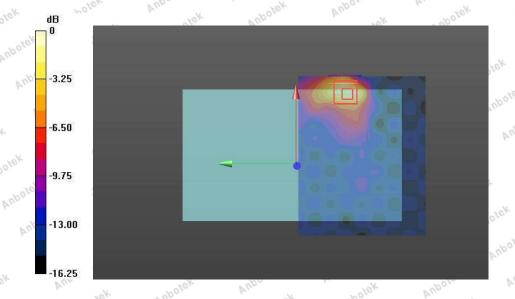
BODY/Back /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 5.628 V/m; Power Drift = 0.11 dB

Peak SAR (extrapolated) = 0.730 W/kg

SAR(1 g) = 0.436 W/kg; SAR(10 g) = 0.224 W/kg

Maximum value of SAR (measured) = 0.456 W/kg



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Appendix A. DASY System Calibration Certificate

Schmid & Partner Engineering AG

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Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

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To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

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11.12.2009

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst S Service suisse d'étalonnage Servizio svizzero di taratura S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Anbotek (Auden) Client

Accreditation No.: SCS 0108

Certificate No: DAE4-387_Sep02

CALIBRATION CERTIFICATE

Object

DAE4 - SD 000 D04 BM - SN: 387

Calibration procedure(s)

QA CAL-06.v29

Calibration procedure for the data acquisition electronics (DAE)

Calibration date:

September 02, 2024

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration	
Keithley Multimeter Type 2001	SN: 0810278	15-Aug-24 (No:22092)	Aug-24	
Secondary Standards	ID#	Check Date (in house)	Scheduled Check	
Auto DAE Calibration Unit	SE UWS 053 AA 1001	05-Jan-24 (in house check)	In house check: Jan-24	
Calibrator Box V2.1	SE UMS 006 AA 1002	05-Jan-24 (in house check)	In house check: Jan-24	

Calibrated by:

Dominique Steffen

Function Laboratory Technician

Signature

Approved by:

Sven Kühn Deputy Manager

Issued: September 02, 2024

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Certificate No: DAE4-387_Sep02

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Code: AB-RF-05-b





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Email: service@anbotek.com



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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

Glossary

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DAE data acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement. Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal High Range: 1LSB = 6.1µV, full range = -100...+300 mV Low Range: 1LSB = 61nV, full range = -1.....+3mV DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Υ	Z
High Range	404.489 ± 0.02% (k=2)	404.852 ± 0.02% (k=2)	404.862 ± 0.02% (k=2)
Low Range	Colorida de la colorida del colorida de la colorida del colorida de la colorida del la colorida de la colorida del la col	3.95875 ± 1.50% (k=2)	

Connector Angle

Connector Angle to be used in DASY system	53.0 ° ± 1 °

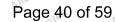
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (µV)	Difference (μV)	Error (%)
Channel X + Input	200032.85	-3.31	-0.00
Channel X + Input	20007.64	1.88	0.01
Channel X - Input	-20003.48	1.18	-0.01
Channel Y + Input	200034.23	-1.43	-0.00
Channel Y + Input	20006.60	0.91	0.00
Channel Y - Input	-20004.04	0.72	-0.00
Channel Z + Input	200035.38	-0.83	-0.00
Channel Z + Input	20003.69	-2.11	-0.01
Channel Z - Input	-20006.38	-1.59	0.01

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.63	0.08	0.00
Channel X + Input	202.29	0.70	0.35
Channel X - Input	-197.90	0.60	-0.30
Channel Y + Input	2001.33	-0.07	-0.00
Channel Y + Input	200.86	-0.60	-0.30
Channel Y - Input	-199.87	-1.23	0.62
Channel Z + Input	2001.61	0.27	0.01
Channel Z + Input	200.60	-0.70	-0.35
Channel Z - Input	-199.51	-0.85	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (μV)
Channel X	200	UE0.	-1.70	0.33
Channel Y	200	10.70		-0.38
Channel Z	200	7.11	7.89	*

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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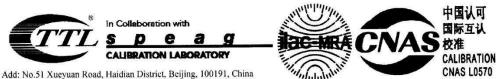
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ent Anbotek (Auden) Certificate No: Z24-98671

CALIBRATION CERTIFICATE

Object EX3DV4 - SN:7396

Calibration Procedure(s)

FF-Z12-006-08

Calibration Procedures for Dosimetric E-field Probes

Calibration date: May 06, 2024

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	101919	20-Jun-23 (CTTL, No.J23 X07447)	Jun-23
Power sensor NRP-Z91	101547	20-Jun-23 (CTTL, No.J23 X07447)	Jun-23
Power sensor NRP-Z91	101548	20-Jun-23 (CTTL, No.J23 X07447)	Jun-23
Reference10dBAttenuator	18N50W-10dB	13-Mar-24(CTTL,No.J24X01547)	Mar-24
Reference20dBAttenuator	18N50W-20dB	13-Mar-24(CTTL, No.J24X01548)	Mar-24
Reference Probe EX3DV4	SN 7433	26-Sep-23(SPEAG,No.EX3-7433_Sep22)	Sep-23
DAE4	SN 549	13-Dec-23(SPEAG, No.DAE4-549_Dec22)	Dec -23
Secondary Standards	ID#	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
SignalGeneratorMG3700A	6201052605	27-Jun-23 (CTTL, No.J23X04776)	Jun-23
Network Analyzer E5071C	MY46110673	13-Jan-24 (CTTL, No.J24X00285)	Jan -24
	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	TO TO
Reviewed by:	Lin Hao	SAR Test Engineer	林杨
Approved by:	Qi Dianyuan	SAR Project Leader	202
		Issued: May06	2024

Issued: May06, 2024

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Probe EX3DV4

SN: 7396

Calibrated: May 06, 2024

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
$Norm(\mu V/(V/m)^2)^A$	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Unc ^E (k=2)
0 CW	cw	X	0.0	0.0	1.0	0.00	199.9	±2.4%
	Υ	0.0	0.0	1.0		203.3		
		Z	0.0	0.0	1.0		195.0	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.

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A The uncertainties of Norm X, Y, Z do not affect the E2-field uncertainty inside TSL (see Page 5 and Page 6).

E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.





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DASY/EASY - Parameters of Probe: EX3DV4 - SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9.71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

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^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.





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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9.82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

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F At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

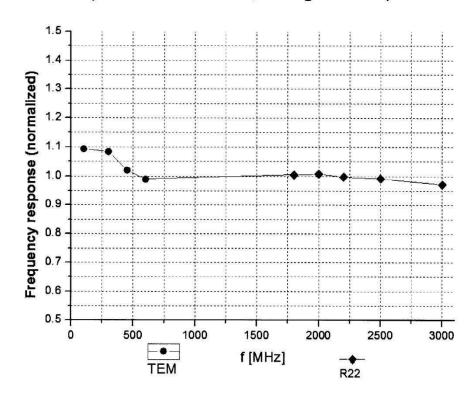






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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ±7.4% (k=2)

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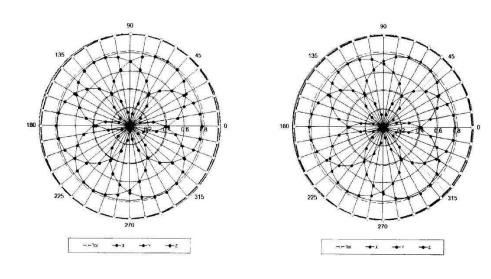


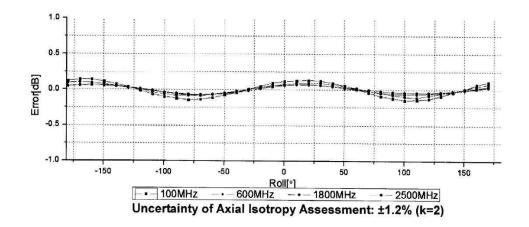
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Receiving Pattern (Φ), θ =0°

f=600 MHz, TEM

f=1800 MHz, R22





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Dynamic Range f(SAR_{head}) (TEM cell, f = 900 MHz) 10⁵ Input Signal[µV] 104 10 10² 10 10° 10 10² 10³ SAR[mW/cm³] not compensated Error[dB] 10-2 10 102 SAR[mW/cm3] not compensated - compensated Uncertainty of Linearity Assessment: ±0.9% (k=2)

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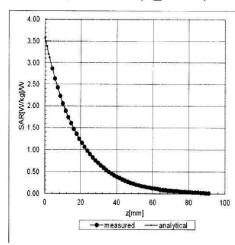


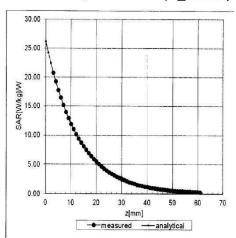
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Conversion Factor Assessment

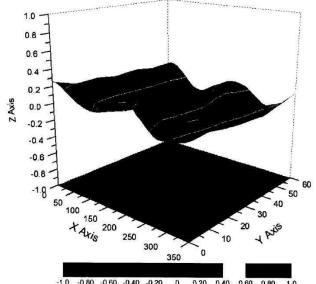
f=900 MHz, WGLS R9(H_convF)

f=1750 MHz, WGLS R22(H_convF)





Deviation from Isotropy in Liquid



-1 0 -0 80 -0 60 -0 40 -0 20 0 0 20 0 40 0 60 0 80 1 0 Uncertainty of Spherical Isotropy Assessment: ±3.2% (K=2)

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